Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/825,594	LEE, YUN-BOK	
Examiner	Art Unit	
Tai Duong	2871	

	SEARCHED						
Ci	ass	Subclass	Date		Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM TDB) see search history printout	11/27/2006	TD		